

<b>Notice of References Cited</b>	Application/Control No. 10/629,930	Applicant(s)/Patent Under Reexamination LEFEBVRE ET AL.	
	Examiner Phu K. Nguyen	Art Unit 2628	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,731,314	05-2004	Cheng et al.	715/848
*	B	US-7,015,919	03-2006	Stauffer et al.	345/543
*	C	US-6,880,129	04-2005	Lee et al.	715/763
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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